

S-57K1 A Series

FOR AUTOMOTIVE 125°C OPERATION HIGH-WITHSTAND VOLTAGE HIGH-SPEED BIPOLAR HALL EFFECT LATCH IC

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Rev. 1.6_01

This IC, developed by CMOS technology, is a high-accuracy Hall effect latch IC that operates with high temperature and high-withstand voltage.

The output voltage changes when this IC detects the intensity level of magnetic flux density and a polarity change. Using this IC with a magnet makes it possible to detect the rotation status in various devices.

This IC includes a reverse voltage protection circuit and an output current limit circuit.

High-density mounting is possible by using the small SOT-23-3 package.

Due to its high-accuracy magnetic characteristics, this IC can make operation's dispersion in the system combined with magnet smaller.

SII Semiconductor Corporation offers a "magnetic simulation service" that provides the ideal combination of magnets and our Hall effect ICs for customer systems. Our magnetic simulation service will reduce prototype production, development period and development costs. In addition, it will contribute to optimization of parts to realize high cost performance.

For more information regarding our magnetic simulation service, contact our sales office.

Caution This product can be used in vehicle equipment and in-vehicle equipment. Before using the product in the purpose, contact to SII Semiconductor Corporation is indispensable.

■ Features

• Pole detection: Bipolar latch

• Output $logic^{*1}$: $V_{OUT} = "L"$ at S pole detection $V_{OUT} = "H"$ at S pole detection

• Output form*1: Nch open-drain output,

Nch driver + built-in pull-up resistor

• Magnetic sensitivity*1: $B_{OP} = 3.0 \text{ mT typ.}$ $B_{OP} = 6.0 \text{ mT typ.}$

• Chopping frequency: $f_C = 500 \text{ kHz typ.}$ • Output delay time: $t_D = 8.0 \mu \text{s typ.}$

• Power supply voltage range: $V_{DD} = 3.5 \text{ V to } 26.0 \text{ V}$

• Built-in regulator

• Built-in reverse voltage protection circuit

• Built-in output current limit circuit

Operation temperature range:

• Lead-free (Sn 100%), halogen-free

AEC-Q100 qualified*2

*1. The option can be selected.

*2. Contact our sales office for details.

Ta = -40° C to $+125^{\circ}$ C

■ Applications

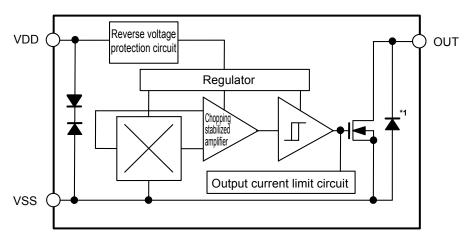
- Automobile equipment
- Home appliance
- DC brushless motor
- Housing equipment
- · Industrial equipment

■ Package

• SOT-23-3

■ Block Diagrams

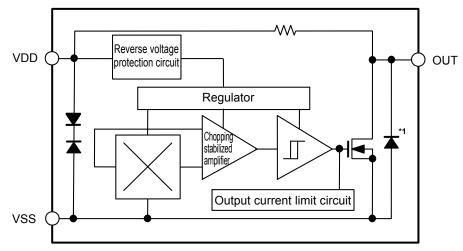
1. Nch open-drain output product



*1. Parasitic diode

Figure 1

2. Nch driver + built-in pull-up resistor product



*1. Parasitic diode

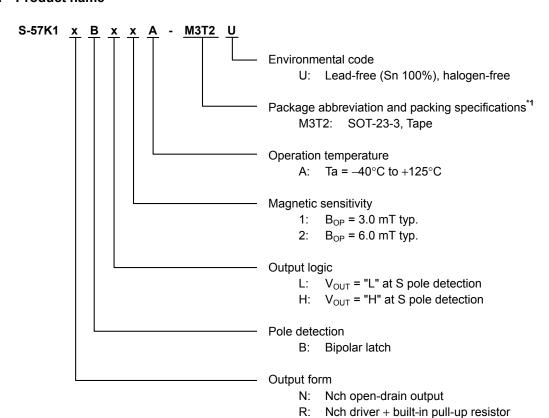
Figure 2

■ AEC-Q100 Qualified

This IC supports AEC-Q100 for operation temperature grade 1. Contact our sales office for details of AEC-Q100 reliability specification.

■ Product Name Structure

1. Product name



^{*1.} Refer to the tape drawing.

2. Package

Table 1 Package Drawing Codes

Package Name	Dimension	Tape	Reel
SOT-23-3	MP003-C-P-SD	MP003-C-C-SD	MP003-Z-R-SD

3. Product name list

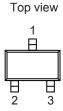
Table 2

Product Name	Output Form	Pole Detection	Output Logic	Magnetic Sensitivity (B _{OP})
S-57K1NBL1A-M3T2U	Nch open-drain output	Bipolar latch	V _{OUT} = "L" at S pole detection	3.0 mT typ.
S-57K1NBL2A-M3T2U	Nch open-drain output	Bipolar latch	V _{OUT} = "L" at S pole detection	6.0 mT typ.
S-57K1NBH1A-M3T2U	Nch open-drain output	Bipolar latch	V _{OUT} = "H" at S pole detection	3.0 mT typ.
S-57K1RBL1A-M3T2U	Nch driver + built-in pull-up resistor	Bipolar latch	V _{OUT} = "L" at S pole detection	3.0 mT typ.

Remark Please contact our sales office for products other than the above.

■ Pin Configuration

1. SOT-23-3



Pin No. Symbol Description

1 VSS GND pin

2 VDD Power supply pin

3 OUT Output pin

Table 3

Figure 3

■ Absolute Maximum Ratings

Table 4

(Ta = $+25^{\circ}$ C unless otherwise specified)

	Item	Symbol	Absolute Maximum Rating	Unit
Power sup	pply voltage	V_{DD}	$V_{SS} - 28.0 \text{ to } V_{SS} + 28.0$	V
Output current		I _{OUT}	20	mA
Output	Output Nch open-drain output product		$V_{SS} - 0.3 \text{ to } V_{SS} + 28.0$	V
voltage	Nch driver + built-in pull-up resistor product	V _{OUT}	$V_{SS} - 0.3$ to $V_{DD} + 0.3$	V
Junction temperature		Tj	-40 to +150	°C
Operation	ambient temperature	T _{opr}	-40 to +125	°C
Storage to	emperature	T _{stg}	-40 to +150	°C

Caution The absolute maximum ratings are rated values exceeding which the product could suffer physical damage. These values must therefore not be exceeded under any conditions.

■ Thermal Resistance Value

Table 5

Item Symbol		Condition		Min.	Тур.	Max.	Unit
	θ_{ja}	SOT-23-3	Board A	1	200	1	°C/W
			Board B	1	165	1	°C/W
Junction-to-ambient thermal resistance*1			Board C	1	1	1	°C/W
			Board D	ı	ı	I	°C/W
			Board E	_	_	_	°C/W

^{*1.} Test environment: compliance with JEDEC STANDARD JESD51-2A

Remark Refer to "■ Power Dissipation" and "Test Board" for details.

■ Electrical Characteristics

Table 6

(Ta = +25°C, V_{DD} = 12.0 V, V_{SS} = 0 V unless otherwise specified)

Item	Symbol	Condition	Min.	Тур.	Max.	Unit	Test Circuit
Power supply voltage	V_{DD}	-	3.5	12.0	26.0	V	_
Current consumption	1	Nch open-drain output product Average value	_	3.0	4.0	mA	1
Current consumption	I _{DD}	Nch driver + built-in pull-up resistor product Average value, V _{OUT} = "H"	_	3.0	4.0	mA	1
Current consumption		Nch open-drain output product $V_{DD} = -26.0 \text{ V}$	-1	1	_	mA	1
during reverse connection	I _{DDREV}	Nch driver + built-in pull-up resistor product $V_{DD} = -26.0 \text{ V}$	-5	ı	-	mA	1
Output voltage	V	Nch open-drain output product Output transistor Nch, V_{OUT} = "L", I_{OUT} = 10 mA	_	-	0.4	V	2
Output voltage	V _{OUT}	Nch driver + built-in pull-up resistor product Output transistor Nch, V _{OUT} = "L", I _{OUT} = 10 mA	_	-	0.5	V	2
Output drop voltage	V _D	Nch driver + built-in pull-up resistor product V_{OUT} = "H", V_D = V_{DD} - V_{OUT}	_	-	20	mV	2
Leakage current	I _{LEAK}	Nch open-drain output product Output transistor Nch, V_{OUT} = "H" = 26.0 V	_	ı	10	μА	3
Output limit current	I _{OM}	V _{OUT} = 12.0 V	22	-	70	mA	3
Output delay time	t _D	F	_	8.0	_	μs	_
Chopping frequency	f_{C}	1	_	500	_	kHz	_
Start up time	t _{PON}	-	_	20	-	μs	4
Output rise time	4	Nch open-drain output product $C = 20 \text{ pF}, R = 820 \Omega$	_	_	2.0	μs	5
Output rise time	t _R	Nch driver + built-in pull-up resistor product C = 20 pF	_	_	6.0	μs	5
Output fall time	t _F	C = 20 pF, R = 820 Ω	_	_	2.0	μs	5
Pull-up resistor	R_L	Nch driver + built-in pull-up resistor product	7	10	13	kΩ	-

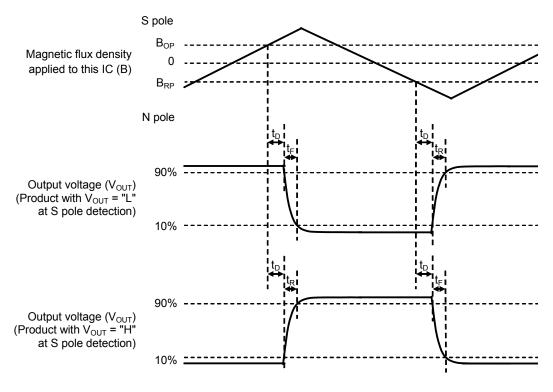


Figure 4 Operation Timing

■ Magnetic Characteristics

1. Product with $B_{OP} = 3.0 \text{ mT typ.}$

Table 7

(Ta = +25°C, V_{DD} = 12.0 V, V_{SS} = 0 V unless otherwise specified)

Item		Symbol	Condition	Min.	Тур.	Max.	Unit	Test Circuit
Operation point*1	S pole	B _{OP}	_	1.5	3.0	4.5	mT	4
Release point*2	N pole	B _{RP}	_	-4.5	-3.0	-1.5	mT	4
Hysteresis width*3		B _{HYS}	$B_{HYS} = B_{OP} - B_{RP}$	-	6.0	ı	mT	4

2. Product with $B_{OP} = 6.0 \text{ mT typ.}$

Table 8

(Ta = +25°C, V_{DD} = 12.0 V, V_{SS} = 0 V unless otherwise specified)

Item		Symbol	Condition	Min.	Тур.	Max.	Unit	Test Circuit
Operation point*1	S pole	B _{OP}	_	3.0	6.0	9.0	mT	4
Release point*2	N pole	B _{RP}	_	-9.0	-6.0	-3.0	mT	4
Hysteresis width*3		B _{HYS}	$B_{HYS} = B_{OP} - B_{RP}$	_	12.0	_	mT	4

^{*1.} B_{OP}: Operation point

 B_{OP} is the value of magnetic flux density when the output voltage (V_{OUT}) changes after the magnetic flux density applied to this IC by the magnet (S pole) is increased (by moving the magnet closer).

V_{OUT} retains the status until a magnetic flux density of the N pole higher than B_{RP} is applied.

***2.** B_{RP} : Release point

 B_{RP} is the value of magnetic flux density when the output voltage (V_{OUT}) changes after the magnetic flux density applied to this IC by the magnet (N pole) is increased (by moving the magnet closer).

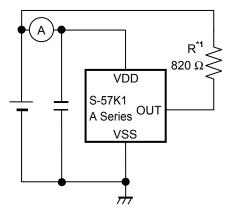
 V_{OUT} retains the status until a magnetic flux density of the S pole higher than B_{OP} is applied.

*3. B_{HYS}: Hysteresis width

 B_{HYS} is the difference of magnetic flux density between B_{OP} and B_{RP} .

Remark The unit of magnetic density mT can be converted by using the formula 1 mT = 10 Gauss.

■ Test Circuits



*1. Resistor (R) is unnecessary for Nch driver + built-in pull-up resistor product.

Figure 5 Test Circuit 1

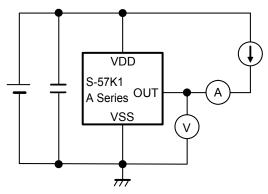


Figure 6 Test Circuit 2

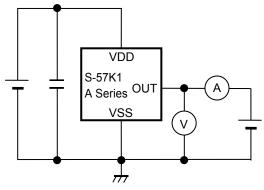
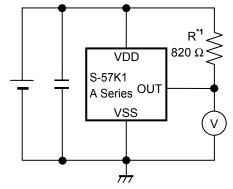
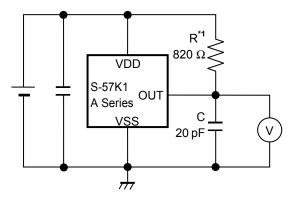


Figure 7 Test Circuit 3



*1. Resistor (R) is unnecessary for Nch driver + built-in pull-up resistor product.

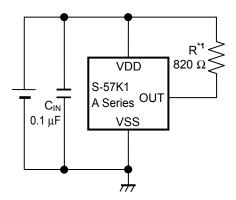
Figure 8 Test Circuit 4



*1. Resistor (R) is unnecessary for Nch driver + built-in pull-up resistor product.

Figure 9 Test Circuit 5

■ Standard Circuit



*1. Resistor (R) is unnecessary for the pull-up resistor built-in product.

Figure 10

Caution The above connection diagram and constant will not guarantee successful operation. Perform thorough evaluation using the actual application to set the constant.

■ Operation

1. Direction of applied magnetic flux

This IC detects the magnetic flux density which is vertical to the marking surface.

Figure 11 shows the direction in which magnetic flux is being applied.

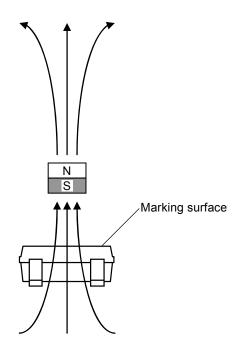


Figure 11

2. Position of Hall sensor

Figure 12 shows the position of Hall sensor.

The center of this Hall sensor is located in the area indicated by a circle, which is in the center of a package as described below.

The following also shows the distance (typ. value) between the marking surface and the chip surface of a package.

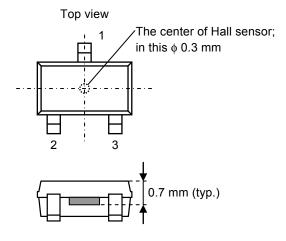


Figure 12

3. Basic operation

This IC changes the output voltage (V_{OUT}) according to the level of the magnetic flux density and a polarity change (N pole or S pole) applied by a magnet.

3. 1 Product with V_{OUT} = "L" at S pole detection

When the magnetic flux density of the S pole perpendicular to the marking surface exceeds the operation point (B_{OP}) after the S pole of a magnet is moved closer to the marking surface of this IC, V_{OUT} changes from "H" to "L". When the N pole of a magnet is moved closer to the marking surface of this IC and the magnetic flux density of the N pole is higher than the release point (B_{RP}), V_{OUT} changes from "L" to "H". In case of $B_{RP} < B < B_{OP}$, V_{OUT} retains the status. **Figure 13** shows the relationship between the magnetic flux density and V_{OUT} .

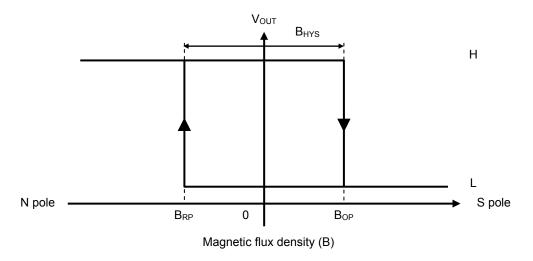


Figure 13

3. 2 Product with V_{OUT} = "H" at S pole detection

When the magnetic flux density of the S pole perpendicular to the marking surface exceeds B_{OP} after the S pole of a magnet is moved closer to the marking surface of this IC, V_{OUT} changes from "L" to "H". When the N pole of a magnet is moved closer to the marking surface of this IC and the magnetic flux density of the N pole is higher than B_{RP} , V_{OUT} changes from "H" to "L". In case of $B_{RP} < B < B_{OP}$, V_{OUT} retains the status.

Figure 14 shows the relationship between the magnetic flux density and V_{OUT}.

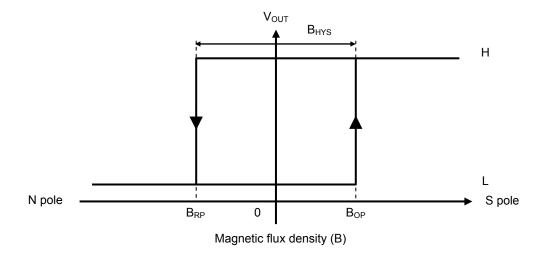


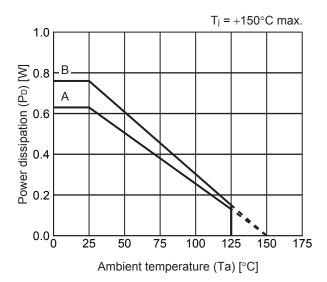
Figure 14

■ Precautions

- If the impedance of the power supply is high, the IC may malfunction due to a supply voltage drop caused by feed-through current. Take care with the pattern wiring to ensure that the impedance of the power supply is low.
- Note that the IC may malfunction if the power supply voltage rapidly changes. When the IC is used under the
 environment where the power supply voltage rapidly changes, it is recommended to judge the output voltage of the IC
 by reading it multiple times.
- Do not apply an electrostatic discharge to this IC that exceeds the performance ratings of the built-in electrostatic protection circuit.
- Although this IC has a built-in output current limit circuit, it may suffer physical damage such as product deterioration under the environment where the absolute maximum ratings are exceeded.
- Although this IC has a built-in reverse voltage protection circuit, it may suffer physical damage such as product deterioration under the environment where the absolute maximum ratings are exceeded.
- The application conditions for the power supply voltage, the pull-up voltage, and the pull-up resistor should not exceed the power dissipation.
- Large stress on this IC may affect on the magnetic characteristics. Avoid large stress which is caused by the handling during or after mounting the IC on a board.
- SII Semiconductor Corporation claims no responsibility for any disputes arising out of or in connection with any infringement by products including this IC of patents owned by a third party.

■ Power Dissipation

SOT-23-3



 Board
 Power Dissipation (PD)

 A
 0.63 W

 B
 0.76 W

 C

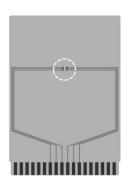
 D

 E

SOT-23-3/5/6 Test Board

(1) Board A





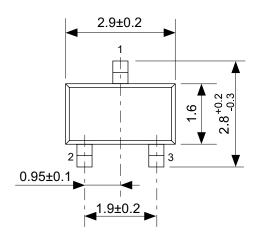
Item		Specification		
Size [mm]		114.3 x 76.2 x t1.6		
Material		FR-4		
Number of copper foil layer		2		
	1	Land pattern and wiring for testing: t0.070		
Coppor foil lover [mm]	2	-		
Copper foil layer [mm]	3	-		
	4	74.2 x 74.2 x t0.070		
Thermal via		-		

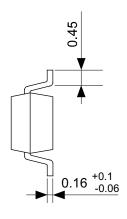
(2) Board B

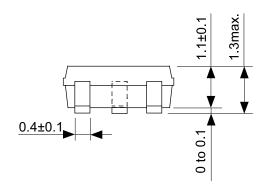


Item		Specification		
Size [mm]		114.3 x 76.2 x t1.6		
Material		FR-4		
Number of copper foil layer		4		
	1	Land pattern and wiring for testing: t0.070		
Copper foil layer [mm]	2	74.2 x 74.2 x t0.035		
Copper foli layer [min]	3	74.2 x 74.2 x t0.035		
	4	74.2 x 74.2 x t0.070		
Thermal via		-		

No. SOT23x-A-Board-SD-1.0



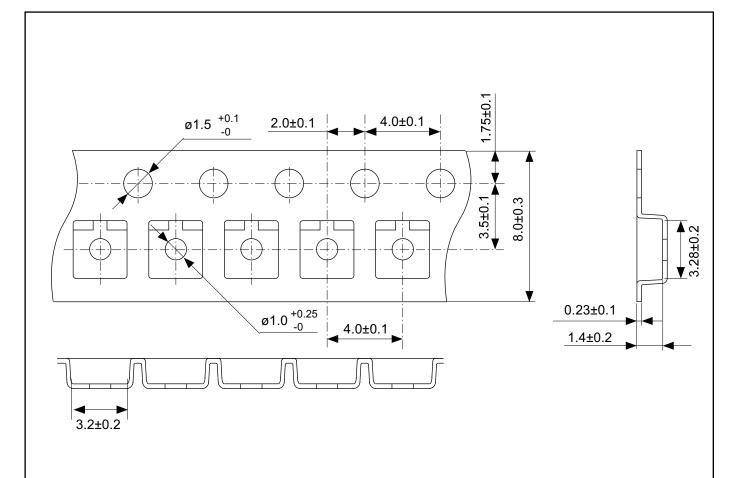


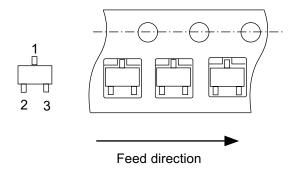


No. MP003-C-P-SD-1.1

TITLE	SOT233-C-PKG Dimensions				
No.	MP003-C-P-SD-1.1				
ANGLE	\$				
UNIT	mm				
CII Cominanduator Corneration					

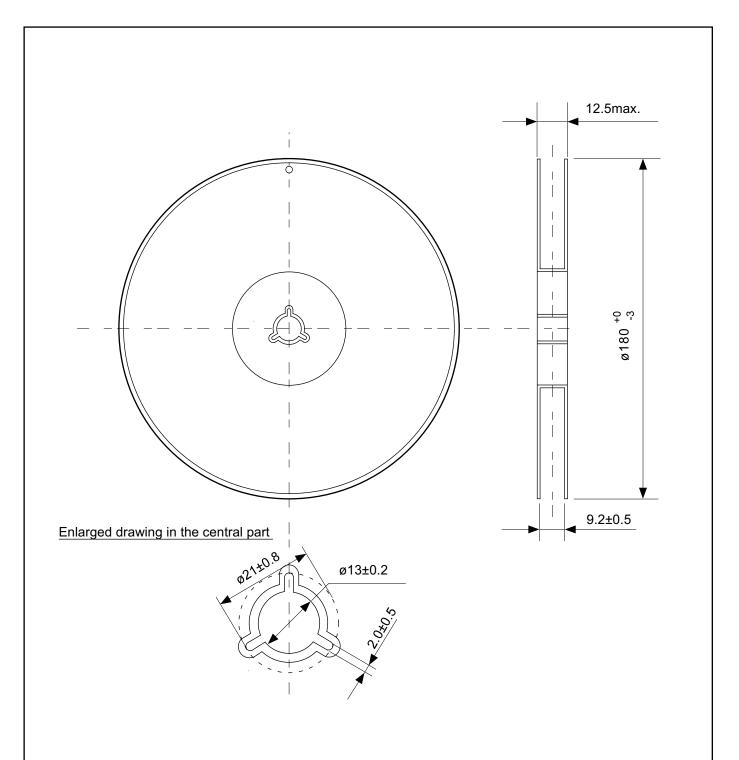
SII Semiconductor Corporation





No. MP003-C-C-SD-2.0

TITLE	SOT233-C-Carrier Tape			
No.	MP003-C-C-SD-2.0			
ANGLE				
UNIT	mm			
SII Semiconductor Corporation				



No. MP003-Z-R-SD-1.0

TITLE	SOT233-C-Reel						
No.	MP003-Z-R-SD-1.0						
ANGLE		QTY.	3,000				
UNIT	mm						
SII Semiconductor Corporation							

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